

<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10642299	CHEN ET AL.
	Examiner Menon, Krishnan S	Art Unit 1723

Notes	Date	Examiner
210/498, 348, 483, 488, 645, 650; 422/68.1, 101, 102, 129, 138; 137/833; 366/341	6/14/06	KM

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Class	SubClass	Date	Examiner
PGPUB.CLM.		6/14/06	KM

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